

# Search Notes



Application/Control No.

10/802,887

Examiner

Mark A. Chapman

Applicant(s)/Patent under  
Reexamination

TANAKA ET AL.

Art Unit

1756

## SEARCHED

Class	Subclass	Date	Examiner
430	109.4	5/9/2006	MC
	137.17		
	108.3		
<i>update</i>		<i>12/06 me</i>	

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
<i>430</i>	<i>109.4</i>	<i>12/06</i>	<i>me</i>
	<i>137.17</i>		
	<i>108.3</i>		

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
east	5/9/2006	MC
<i>update</i>	<i>12/06 me</i>	